

# Search Notes



Application/Control No.

09/940,189

Examiner

Wei Y. Zhen

Applicant(s)/Patent under Reexamination

VAZQUEZ ET AL.

Art Unit

2191

## SEARCHED

Class	Subclass	Date	Examiner
717	106-109 115 101-105	6/21/05	WZ
	123	↓	↓
700	83, 219 264	↓	↓

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
WEST	6/22/05	WZ